Draft for Public Comment

Form 36

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BSI Group Headquarters

389 Chiswick High Road London W4 4AL

Tel: +44 (0)20 8996 9000
Fax: +44 (0)20 8996 7400
www.bsigroup.com

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Project No. 2024/02106

Responsible committee: EPL/47 Semiconductors

Interested committees:

Title: BS EN IEC 60749-24 Semiconductor devices - Mechanical and climatic test methods

Part 24: Accelerated moisture resistance - Unbiased HAST

Please notify the secretary if you are aware of any keywords that might assist in classifying or identifying the standard or if the content of this standard
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ii) affects other national standard(s)
iii) requires additional national guidance or information

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Responsible Committee Secretary: **Committee Service Centre (BSI)**
Direct tel: **020 8996 7009**
E-mail: **csc@bsigroup.com**

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Introduction

This draft standard is based on national and international discussions. Your comments on this draft are invited and will assist in the preparation of the consequent standard.

For international standards, comments will be reviewed by the relevant UK national committee before sending the consensus UK vote and comments to the international committee, which will then decide appropriate action. If the international standard is approved, it is usual for the text to be published as a British Standard.

For national standards, comments will be reviewed by the relevant UK national committee and the resulting standards published as a British Standard.

UK Vote

Please indicate whether you consider the UK should submit a negative (with supporting technical reasons) or positive vote on this draft. Please indicate if you are aware of any reason why this draft standard should not be published as a British Standard.

Submission of Comments

- **Annotated drafts are not acceptable and will be rejected.**
- All comments should be submitted online at **https://standardsdevelopment.bsigroup.com/**. You will need to register in order to comment.

Template for comments and secretariat observations

Date: xx/xx/20xx	Document: ISO/DIS xxxx

1	2	(3)	4	5	(6)	7
MB	Clause No./ Subclause No./Annex **(e.g. 3.1)**	Paragraph/Figure/ Table/Note	**Type of comment**	**Commend (justification for change) by the MB**	**Proposed change by the MB**	**Secretariat observations on each comment submitted**
	3.1	Definition 1	ed	Definition is ambiguous and needs clarifying.	Amend to read '...so that the mains connector to which no connection...'	
	6.4	Paragraph 2	te	The use of the UV photometer as an alternative cannot be supported as serious problems have been encountered in its use in the UK.	Delete reference to UV photometer.	

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47/2863/CDV

COMMITTEE DRAFT FOR VOTE (CDV)

PROJECT NUMBER: **IEC 60749-24 ED2**	
DATE OF CIRCULATION: **2024-09-06**	CLOSING DATE FOR VOTING: **2024-11-29**
SUPERSEDES DOCUMENTS: **47/2858/RR**	

IEC TC 47 : SEMICONDUCTOR DEVICES	
SECRETARIAT: Korea, Republic of	SECRETARY: Mr Cheolung Cha
OF INTEREST TO THE FOLLOWING COMMITTEES: TC 91,TC 104	HORIZONTAL FUNCTION(S):
ASPECTS CONCERNED: Environment,Safety	
☐ SUBMITTED FOR CENELEC PARALLEL VOTING	☒ NOT SUBMITTED FOR CENELEC PARALLEL VOTING

This document is still under study and subject to change. It should not be used for reference purposes.

Recipients of this document are invited to submit, with their comments, notification of any relevant patent rights of which they are aware and to provide supporting documentation.

Recipients of this document are invited to submit, with their comments, notification of any relevant “In Some Countries” clauses to be included should this proposal proceed. Recipients are reminded that the CDV stage is the final stage for submitting ISC clauses. (SEE AC/22/2007 OR NEW GUIDANCE DOC).

TITLE:

Semiconductor devices - Mechanical and climatic test methods - Part 24: Accelerated moisture resistance - Unbiased HAST

PROPOSED STABILITY DATE: 2030

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CONTENTS

1 Scope 5
2 Normative references 5
3 Test requirements 5
4 Test apparatus 6
4.1 Test chamber 6
4.2 Records 6
4.3 Devices under stress 6
4.4 Ionic contamination 6
4.5 Distilled or deionized water 6
5 Test conditions 6
6 Procedure 7
6.1 Mounting 7
6.2 Ramp-up 7
6.3 Ramp-down 8
6.4 Test clock 8
6.5 Electrical tests 8
6.6 Handling 8
7 Failure criteria 8
8 Safety 8
9 Summary 9

Table 1 – Temperature, relative humidity, and pressure 7

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